

 <p>FORM HDP-1449 (Based on Form PTO-1449)</p> <p style="text-align: center;"><b>PATENT AND TRADEMARK OFFICE</b>  <b>INFORMATION DISCLOSURE CITATION</b>          (Use several sheets if necessary)</p> <p style="text-align: center;">Sheet 1 of 4</p>	ATTORNEY DOCKET No.	SERIAL No.
	1740-000040/US	10/762,538
	APPLICANT	
	Sang Woon SUH et al.	
	FILING DATE	GROUP
January 23, 2004	2627	

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Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
1.		5,572,507	11/05/1996	Ozaki et al.		
2.		5,689,486	11/18/1997	Shimizu et al.		
3.		5,737,286	04/07/1998	Timmermans et al.		
4.		5,799,501	09/01/1998	Leonard et al.		
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7.		6,353,890 B1	03/05/2002	Newman		
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11.		6,664,526 B2	12/16/2003	Yokoi		
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22.		EP 0 299 573 B1	01/18/1989	Europe		N/A	
23.		EP 0 807 929 A1	11/19/1997	Europe		N/A	

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Date Considered:

EXAMINER: Please initial if citation considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

<b>FORM HDP-1449 (Based on Form PTO-1449)</b>  <b>PATENT AND TRADEMARK OFFICE</b> <b>INFORMATION DISCLOSURE CITATION</b> (Use several sheets if necessary)  Sheet 2 of 4	ATTORNEY DOCKET No.	SERIAL No.
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24.		EP 1 028 423 B1	08/16/2000	Europe		N/A	
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26.		EP 1 122 729 A1	08/08/2001	Europe		N/A	
27.		EP 1 152 412 A1	11/07/2001	Europe		N/A	
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62.		Russian Office Action date January 30, 2007 for Russian Application No. 2006109209
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64.		U.S. Office Action dated April 17, 2007 for U.S. Application No. 10/762,538
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72.	U.S. Office Action dated November 19, 2007 for U.S. Application No. 10/762,536
73.	Japanese Patent Office Action dated January 16, 2008 for Japanese Application No. 2006-76406
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80.	European Patent Office Action dated March 26, 2008 for European Application No. 070184-5.6
81.	European Patent Office Action dated April 2, 2008 for European Application No. 04703277.6
82.	U.S. Office Action dated June 6, 2008 for U.S. Application No. 10/762,535

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